The project MessLeha analyses measurement methods and environments for the characterization of fast switching power semiconductors and develops a digital datasheet suitable for all simulation tools.

We invite you to discuss these topics with us during an online workshop on

- **04 March 2021, 09:30 – 13:45 (CET)**

The feedback and stakeholder requirements gathered in two breakout sessions will be included in the ongoing work and the resulting standardization proposals for the International Electrotechnical Commission IEC.

**MessLeha Workshop – Seeking feedback from stakeholders…**

…during two breakout sessions

- Machine-readable Datasheet
- Double Pulse Test Setups

**Feedback from the workshop**

2 standardization proposals drafted by MessLeha

Supported by:

- DKE, VDE DIN
- Infineon
- Pe-Systems
- PTB
- Universität Stuttgart
- Federal Ministry for Economic Affairs and Energy

on the basis of a decision by the German Bundestag

**Registration**

The workshop is aimed at users and developers of power electronic systems as well as manufacturers of power semiconductor and simulation tools.

Register [here](#) until **01 March 2021**. The workshop is free of charge.

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Agenda

04 March 2021, Online Workshop

09:30 – 09:40 Welcome and Introduction
Alexandra Fabricius, VDE DKE

09:40 – 09:50 Converter Design: But Where Do I Find the Right Device Model?
How a Machine-Readable Datasheet Can Speed up the Design Process
Anna-Lena Heller, PE-Systems GmbH

09:50 – 10:00 Double Pulse Testing of Fast Switching Devices: Challenges and Opportunities
Uwe Jansen, Infineon Technologies AG

10:00 – 10:20 Challenges in Switching-Loss Determination of Fast-Switching Wide-Bandgap Semiconductors
Ying Su, PTB Physikalisch Technische Bundesanstalt
Dominik Koch, University of Stuttgart
Philipp Ziegler, University of Stuttgart

10:20 – 10:30 Switch to Breakout Sessions

10:30 – 12:00 Breakout Sessions

Track 1: Machine-readable Datasheet: Requirements, Hurdles, Solutions

Vendors of power semiconductor devices have to decide for which of the available simulation tools they provide a model. How convenient the setup of a simulation for a customer is depends on whether they use the “right” tool. In the worst case, the device will not be considered due to the lack of a suitable model. By providing a machine-readable datasheet, the process of device model parametrization can be automated by the toolchain manufacturers. During the breakout session, all stakeholders are able to name and discuss their requirements to be taken up by the project in the standardization activities.

Track 2: Double Pulse Test Setups: Capabilities, Targets, Gaps

Double pulse testing of power semiconductors is a well-established method for power device characterization at the device manufacturer but with the introduction of wide bandgap devices like SiC new challenges arise. On the other hand, many design engineers are not aware what additional benefits double pulse testing in their own setup could provide. In an interactive session we will collect inputs from the participants to evaluate to what extent the MessLeha project already addresses the gaps and where further work is needed.

12:00 – 13:00 Lunch Break

13:00 – 13:30 Workshop Summary and Results
MessLeha Partners

13:30 – 13:40 Next Steps

13:40 – 13:45 Closing Remarks
Alexandra Fabricius, VDE DKE